

## US006506686B2

# (12) United States Patent

Masuda et al.

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### (54) PLASMA PROCESSING APPARATUS AND PLASMA PROCESSING METHOD

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U.S.C. 154(b) by 13 days.

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(30)Foreign Application Priority Data

Mar. 6, 2000 (JP) ...... 2000-065769 (51) Int. Cl.<sup>7</sup> ...... H01L 21/00 (52) U.S. Cl. ...... 438/715; 156/345.44; 156/345.46;

156/345.48; 156/345.49; 216/68; 216/70; (58) **Field of Search** ...... 156/345 P, 345 C,

> 156/345 ME, 345 MG, 345 PH; 438/710, 715, 728, 729, 732; 216/67, 70, 71, 68

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#### (57) **ABSTRACT**

In a plasma processing apparatus that has a vacuum chamber, a process gas supply means of supply gas to a processing chamber, an electrode to hold a sample inside said vacuum chamber, a plasma generator installed in said vacuum chamber opposite to said sample, and a vacuum exhaust system to decrease pressure of said vacuum chamber, a bias voltage of Vdc=-300 to -50 V is applied and the surface temperature of said plate ranges from 100 to 200° C. In addition, the surface temperature fluctuation of the silicon-made plate in said plasma processing apparatus is kept within ±25° C.

### 10 Claims, 7 Drawing Sheets

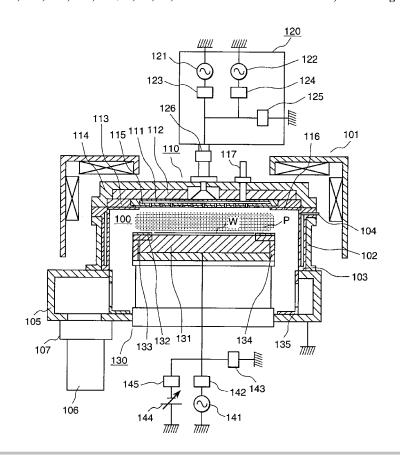




FIG. 1

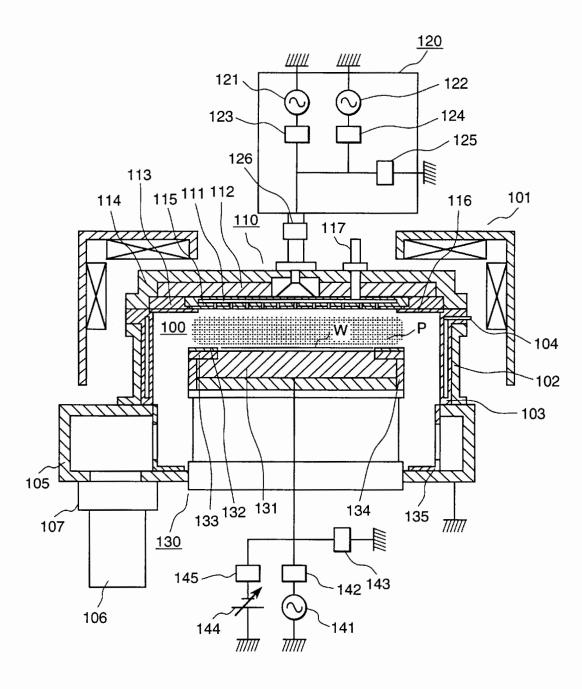
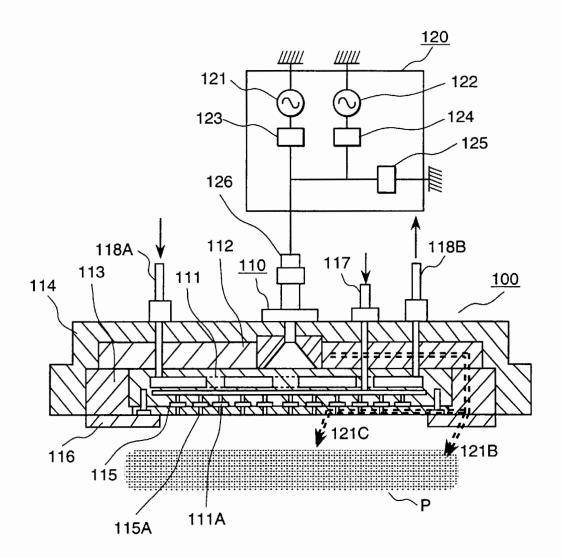




FIG. 2





Si ETCHING RATE (  $\mu$  m/h)

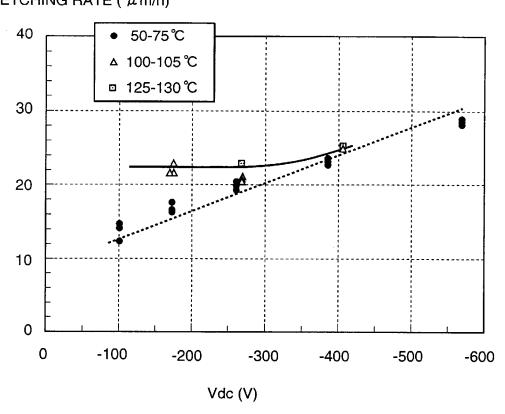


FIG. 4

## TEMPERATURE (deg)

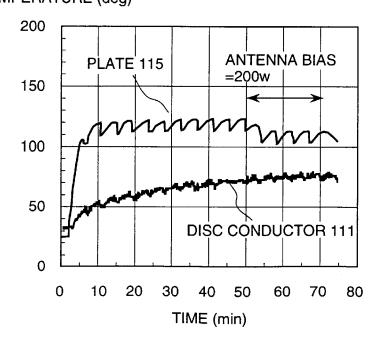




FIG. 5

TEMPERATURE (deg)

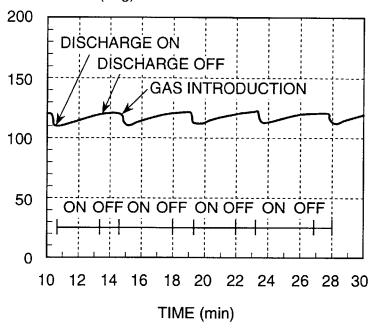
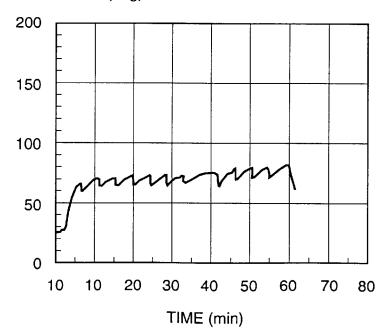


FIG. 6

## TEMPERATURE (deg)





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